Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/530,084	Reexamination HAENEN ET AL.	
Examiner	Art Unit	
SATHAVARAM I REDDY	1794	Page 1 of 1

U.S. PATENT DOCUMENTS

	Old First December 1				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,460,637	07-1984	Miyamoto et al.	428/32.32
*	В	US-5,437,913	08-1995	Asaka et al.	428/195.1
*	С	US-5,418,078	05-1995	Desie et al.	428/32.3
*	D	US-4,408,010	10-1983	Le-Khac, Bi	525/73
*	Е	US-5,418,110	05-1995	Uytterhoeven et al.	430/200
	F	US-			
	G	US-		-	
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 0803 374	10-1997	Japan	Liu et al	
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*	NON-FAIGH DOCUMENTS			
_		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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